

ABSTRACT OF THE DISCLOSURE

A method of repairing a light emitting device which makes high quality image display possible even if a pin hole is formed during formation of an EL layer is provided.

The method of repairing a light emitting device is characterized in that a reverse bias
5 voltage is applied to an EL element at given time intervals to thereby reduce a current
flowing into an EL element when the reverse bias voltage is applied to the EL element.